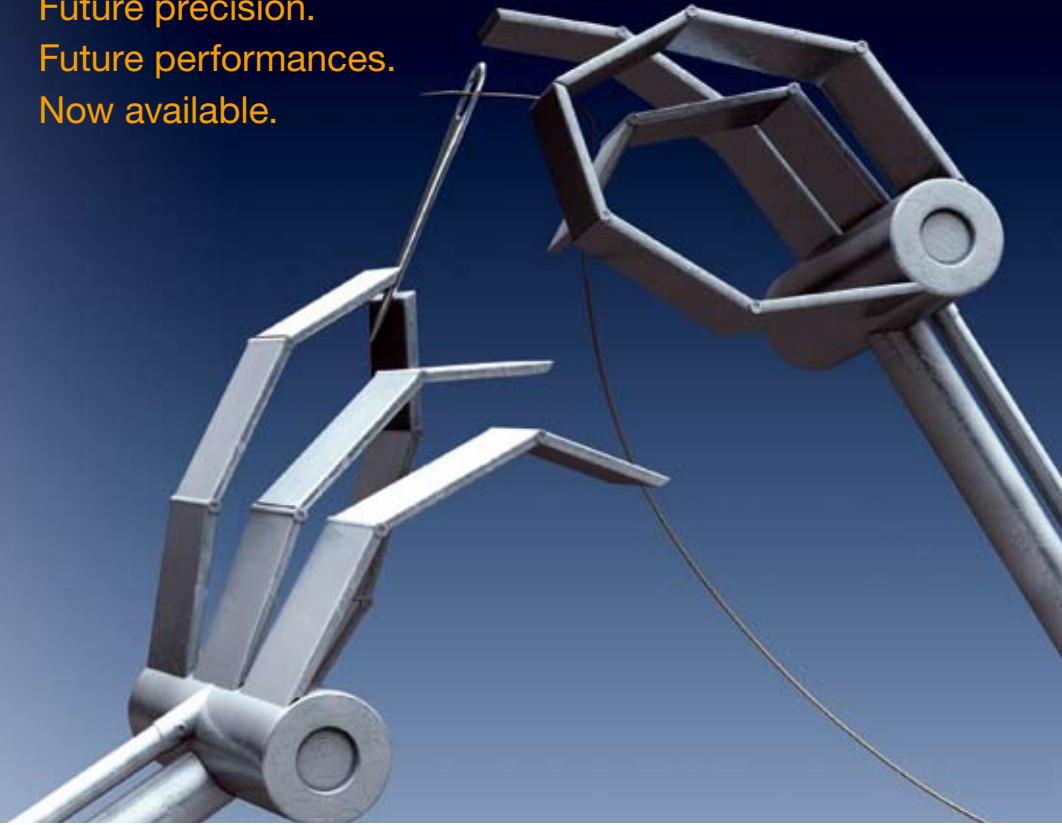


CAS/CASR/CKSR series Current Transducers

Insulated Highly Accurate Measurements
from 1.5 to 50 A_{RMS}



Future precision.
Future performances.
Now available.



CAS/CASR/CKSR series Current Transducers Insulated Highly Accurate Measurements from 1.5 to 50 A_{RMS}

The Power Electronics market is in constant change and always on the lookout for new technologies and better performance driving our progress. To enable applications with enhanced performance, current measurement must always be made with the best possible performance also allowing to the final application to differentiate itself from all the others.

This is the human nature and allows the progress of technology.

With the LTS/LTSR current transducers using the Closed Loop Hall effect technology coupled with a dedicated ASIC (Application Specific Integrated Circuit) specially designed for these products, we thought we had reached the optimal performance, but this was without taking the eternal human nature into account.

The market required even better accuracy over the temperature ranges maintaining a low price and LEM decided to achieve this goal.

A few months later, LEM delivers the solution with the CAS/CASR/CKSR current transducers series covering nominal current measurements from 1,5 to 50 A_{RMS}.

To respond to these new challenges, the Hall effect technology was no longer the solution. Even if used in a Closed Loop configuration and with the use of a dedicated ASIC as done with the LTS family which allowed a substantial performance improvement notably for the accuracy and the size.

Fluxgate technology was selected enabling both possible targets: the improvement in accuracy and the low price.

Without compromising the advantages of the LTS product such as size, dynamic performances, high measuring range, ect.

LEM has already been using multiple Fluxgate technologies in the past and it was just a question to find the one making the best compromise between price, size and performances.

In order for the products to be able to work in the typical industrial applications, the insulation criteria needed to be respected and a particular attention has then been brought to the mechanical design of the product.

Although we were able to reduce the size even when nobody thought it could still be done, the insulation performances allow usage in standard industrial applications without particular mounting with a rated insulation voltage up to 1000 V_{RMS} (Simple isolation according to EN 50178 standard with following parameters: OV 3, PD2).

The CAS/CASR/CKSR models have been specially designed to respond to the technology advances in drives and inverters in industrial environment requiring better performances in areas such as:

- Common mode influence
- Thermal drift (offset and gain)
- Accuracy (in the whole temperature range)
- Response time
- Insulation
- Size

CAS/CASR/CKSR Transducers Technology: Closed Loop Fluxgate technology

Closed Loop current transducers measure current over wide frequency ranges, including DC. They provide contact-free coupling to the current that needs to be measured as well as safe galvanic isolation and high reliability. Their output signal is an accurate, high-resolution image of the primary current with a very short delay.

In higher frequency ranges these transducers function exactly the same way as (passive) current transformers, where a relatively small induced voltage in the secondary winding is capable to drive the secondary current through the secondary winding and, most important, through the burden resistor. A low induced voltage equals low magnetic flux in the magnetic core, which is the cause for the good accuracy (low flux means a small difference between primary and secondary current linkage¹, too).

For DC and in low-frequency ranges, the induced voltage is too low to be able to drive the secondary current, and the error of simple current transformers will increase with decreasing frequency. In this domain, the magnetic flux density in the core is measured by a sensing element and a voltage is applied to the secondary circuit that in the end keeps the flux density near zero, effectively creating a closed control loop.

The only basic difference between the CAS/CASR/CKSR transducer series and standard Closed Loop transducers of LEM is that the Hall element used for feedback is replaced by a Fluxgate detector. The driving force behind this choice is the need for a “better” feedback, which basically means more voltage per current linkage, a quantity that is called “Open Loop sensitivity”. Given an equal electronic circuit, the zero output of a current transducer (traditionally called “offset” in analogy to operational amplifiers) will be less influenced by changes

in the electronics (e.g. offset variations of the amplifiers used) if the Open Loop sensitivity is higher.

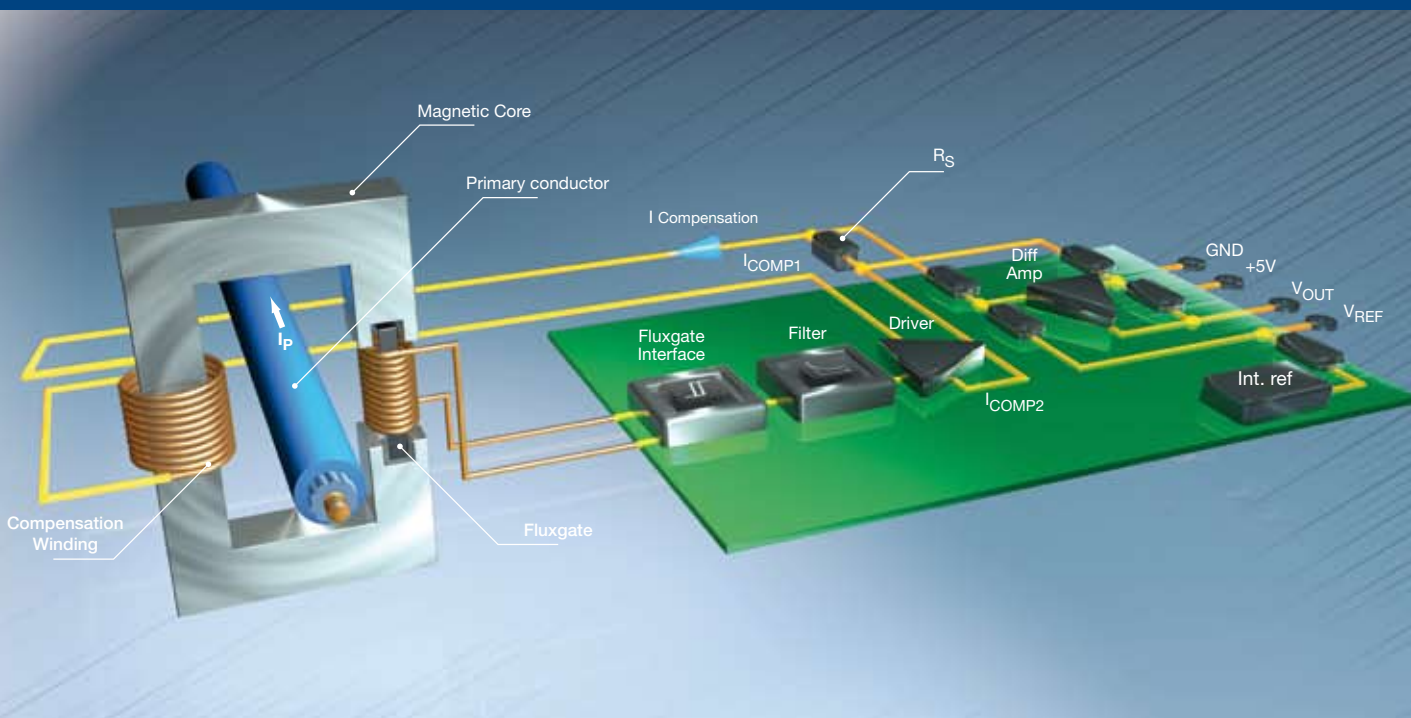
The complexity of a Fluxgate based current transducer is comparable to the one of a transducer based on a Hall effect IC (integrated circuit). Like there, some AC signal processing and synchronous rectifying is applied. In addition, the Fluxgate detector is needed. Fortunately, this Fluxgate is a very simple small solenoid with a tiny soft magnetic strip used as detector core. Because of the complexity of the signal chain, an IC is used to stay at a competitive cost level compared to Hall effect current transducers. A circuit in this IC forms an oscillator together with the Fluxgate, driving it into saturation each half cycle at a frequency of several hundred kilohertz. The effect that is used for the detection of a residual flux in the main transducer core is the fact that in such a configuration a change of the duty cycle of the driving voltage will occur when a magnetic DC flux is present in the fluxgate core.

The signal processing stages in the IC comprise a duty cycle demodulation, frequency response compensation, an integrator and a bridge amplifier that provides the secondary current. This output architecture can provide a higher (doubled) voltage to the secondary circuit when compared to a single output stage with the other side of the circuit connected to a reference potential at typically 2.5 V.

In this configuration, the burden (or measurement) resistor is floating, so in order to obtain an output signal referenced to a fixed voltage, a difference amplifier is used which is also part of the IC.

¹ Current linkage is the technical term for current multiplied by turns count

Fig. 1. Closed Loop Fluxgate Technology used for the CAS/CASR/CKSR current transducers



Mechanical and dimensions

CAS/CASR/CKSR have been designed to provide current measurements from 6 to 50 A_{RMS} in a very compact size compared to the existing current transducers based on different technologies allowing to reach similar electrical performances.

Moreover, the same compact design is used to cover the complete current range from 6 to 50 A_{RMS} with 4

standard models (6 A, 15 A, 25 A and 50 A models) for each series CAS, CASR and CKSR.

The CAS/CASR/CKSR design is **30 % smaller** in height than LTS transducer (Closed Loop Hall effect chip technology using an ASIC): 16.5 mm height versus 24 mm. 7.5 mm won in height!



Where LTS and LTSR were limited to 25 A_{RMS}, with the respective LTS 25-NP and LTSR 25-NP models, as the highest nominal current, the CAS/CASR/CKSR models are offered with a model expected to measure 50 A_{RMS} as nominal current. There has been a requirement from the market for years to have a **100% PCB mounted 50 A_{RMS} current transducer with single + 5 V power supply** in such a class accuracy.

Transducers dimensions

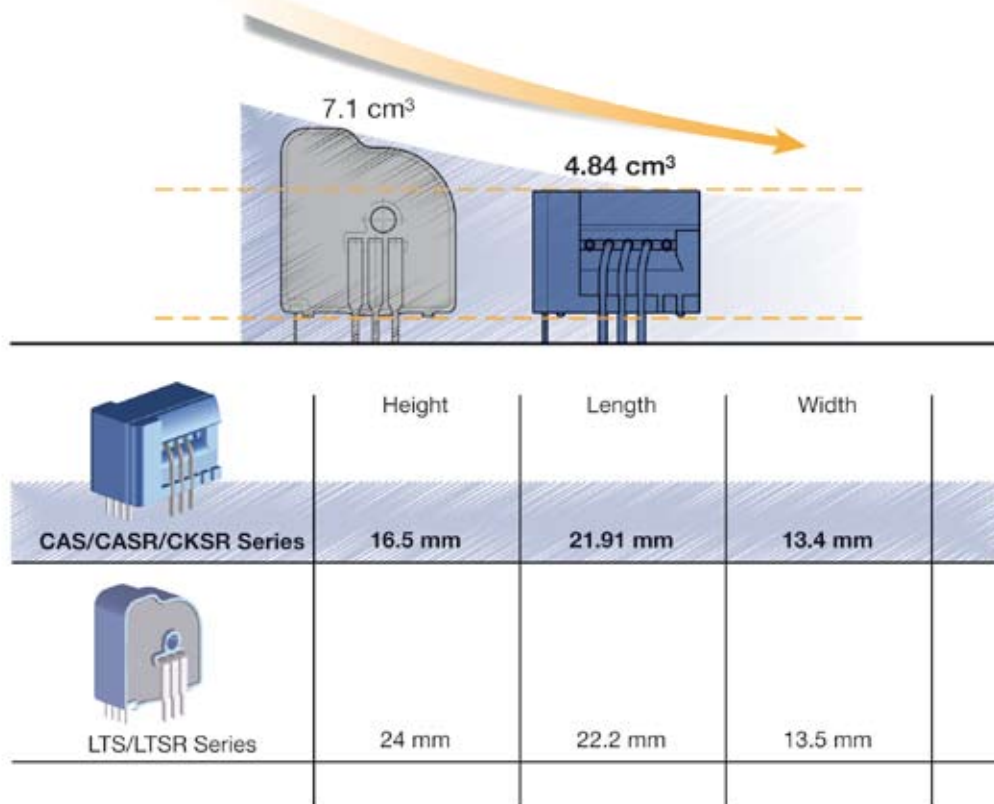

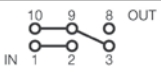
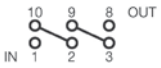


Fig. 2. CAS/CASR/CKSR: 30 % smaller compared to the LTS / LTSR models

Multifunctional primary circuit

The CAS and CASR construction uses three U-shaped primary terminals integrated into the housing, providing the designer with a great flexibility to perfectly adapt the measuring range of the current transducer to his application.

Fig. 4a shows the different connection possibilities.

Number of primary turns	Primary nominal current rms I_{PN} [A]	Nominal* output voltage V_{OUT} [V]	Primary resistance R_p [mΩ] (typ.) at +25° C	Recommended connections
1	± 25	2.5 ± 0.625	0.24	
2	± 12	2.5 ± 0.600	1.08	
3	± 8	2.5 ± 0.600	2.16	

* Output voltage CASR 25-NP is used with internal reference.

Fig. 4a. Different nominal current ranges possible according to the primary current circuit configuration (as example: CAS or CASR 25-NP)

Variant 1

Variant 2

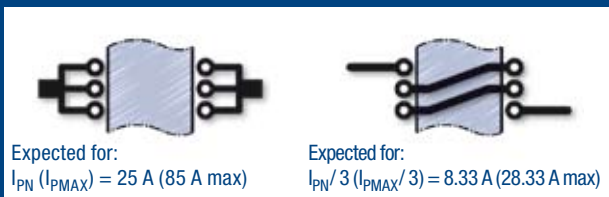


Fig. 4b. The 2 extreme possibilities for connecting the primary current circuit (as example: CAS or CASR 25-NP)

When all three U-shaped terminals are connected in parallel (variant 1 Fig. 4b) the user can measure the maximum nominal primary current.

The variant 2 (Fig.4b) corresponds to a series connection of the primary terminals and leads to a reduction of the nominal measuring range by a factor of 3, but offering a 3 times higher accuracy for low currents.

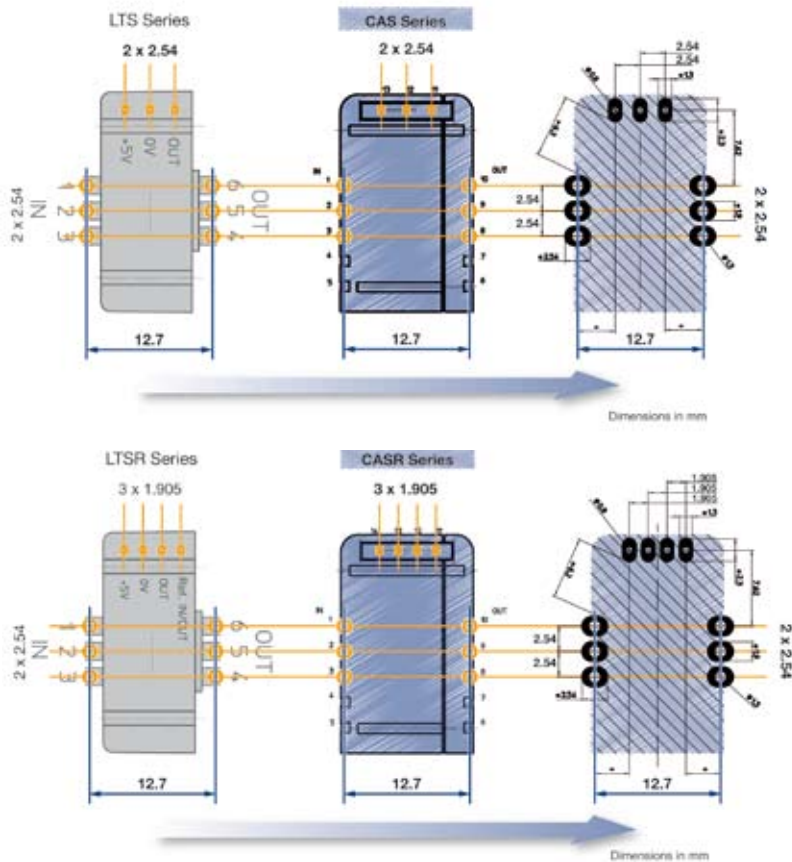

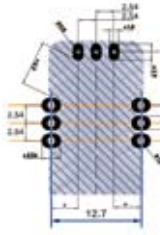

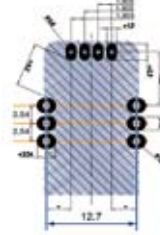

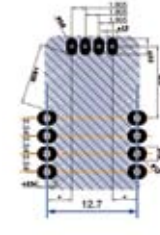


Fig. 3. CAS and CASR transducers can be mounted at the exact place of the LTS and LTSR transducers

The CAS/CASR models are 100% compatible with the LTS and LTSR models in regards to the footprint mounting and also with all the other models that are available on the market with the same footprint as the LTS/LTSR.

CAS/CASR/CKSR Mechanical differences

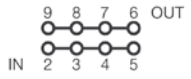
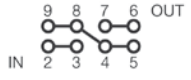
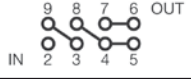
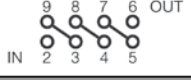
Model	3D drawing	Nominal current range	Nb secondary pins	Ref IN/OUT* on a secondary pin	Nb primary pins	Creepage distance	Clearance distance	Footprint drawing	Compatibility with LTS and LTSR footprints
CAS Series									
CAS 6-NP		6	3	NO	3	7.7 mm	7.7 mm		LTS 6-NP
CAS 15-NP		15	3	NO	3	7.7 mm	7.7 mm		LTS 15-NP
CAS 25-NP		25	3	NO	3	7.7 mm	7.7 mm		LTS 25-NP
CAS 50-NP		50	3	NO	3	7.7 mm	7.7 mm		LTS
CASR Series									
CASR 6-NP		6	4	YES	3	7.5 mm	7.5 mm		LTSR 6-NP
CASR 15-NP		15	4	YES	3	7.5 mm	7.5 mm		LTSR 15-NP
CASR 25-NP		25	4	YES	3	7.5 mm	7.5 mm		LTSR 25-NP
CASR 50-NP		50	4	YES	3	7.5 mm	7.5 mm		LTSR
CKSR Series									
CKSR 6-NP		6	4	YES	4	8.2 mm	8.2 mm		/
CKSR 15-NP		15	4	YES	4	8.2 mm	8.2 mm		/
CKSR 25-NP		25	4	YES	4	8.2 mm	8.2 mm		/
CKSR 50-NP		50	4	YES	4	8.2 mm	8.2 mm		/

* The internal reference voltage is provided on a secondary pin or can be forced by an external reference voltage

The CKSR has one more primary pin (4 primary pins in total) than the CAS and CASR models (3 primary pins in total) making it incompatible with the footprint of these last 8 models. It is possible to measure not less than 1.5 A_{RMS} nominal (using a CKSR 6-NP model set up in one of the 4 possible primary pins layout: Layout with 4 turns. Fig. 5) with the performances mentioned in the CKSR 6-NP data sheet.

Using this layout configuration, the current measured by the transducer is still 6 A_{RMS} (its designed nominal current) as when connected in series the primary pins have 4 loops (instead of 1 when connected in parallel) through the aperture of the transducer.

Then 4 loops, carrying 1.5 A each, results into a total current of 6 A.t (Amps.turn). Finally, the transducer “sees” a 6 A current.

Number of primary turns	Primary nominal current rms I _{PN} [A]	Nominal* output voltage V _{OUT} [V]	Primary resistance R _p [mΩ] (typ.) at +25° C	Recommended connections
1	± 6	2.5 ± 0.625	0.18	
2	± 3	2.5 ± 0.625	0.72	
3	± 2	2.5 ± 0.625	1.8	
4	± 1.5	2.5 ± 0.625	2.88	

* Output voltage CKSR 6-NP is used with internal reference.

Fig. 5. Different nominal current ranges possible according to the primary current circuit configuration – CKSR 6-NP model as example allows nominal current measurement from 1.5 to 6 A_{RMS}

Higher insulation provided with the CKSR models thanks to their mechanical design

The CKSR primary pin footprint is different to the CAS and CASR models.

Thanks to this different primary footprint, higher creepage and clearance distances are achieved.

This can be of interest when higher insulation is required for applications under higher working voltages than normal.

Creepage and clearance distances for **CKSR models** are 8.2 mm (internal distances).

Let's take an example to see the advance this brings.

Conditions of use:

- Creepage distance: 8.2 mm
- Clearance distance: 8.2 mm
- CTI: 600 V (group I)
- Overvoltage category: III
- Pollution Degree: 2

Basic or Single insulation:

According to EN 50178 and IEC 61010-1 standards:

With clearance distance of 8.2 mm and PD2 and OV III, the rated insulation voltage is of $1000 V_{RMS}$.

With a creepage distance of 8.2 mm and PD2 and CTI of 600 V (group I), this leads to a possible rated insulation voltage of $1600 V_{RMS}$.

In conclusion, the possible rated insulation voltage, in these conditions of use, is $1000 V_{RMS}$ (the lowest value given by the both results from the creepage and clearance distances).

Reinforced insulation:

Let's look at the reinforced insulation for the same creepage and clearance distances as previously defined:

When looking at dimensioning reinforced insulation, from the clearance distance point of view, with OV III and according to EN 50178 and IEC 61010-1 standards, the rated insulation voltage is given whatever the pollution degree at $450 V_{RMS}$ (interpolation) or $300 V_{RMS}$ (without interpolation).

From the creepage distance point of view, when dimensioning reinforced insulation, the creepage distance taken into account has to be the real creepage distance divided by 2, that is to say $8.2/2 = 4.1$ mm.

With that value, and PD2 and CTI of 600 V (group I), this leads to a possible rated insulation voltage of $800 V_{RMS}$.

In conclusion, the possible reinforced rated insulation voltage, in these conditions of use, is of $450 V_{RMS}$ (interpolation) or $300 V_{RMS}$ (without interpolation) (the lowest value given by the both results from the creepage and clearance distances).

Using only the EN 50178 standard as a reference for industrial applications, the possible reinforced rated insulation voltage in these conditions of use is of $600 V_{RMS}$.

With **CASR models**, not using the special primary pins footprint, the clearance and creepage distances are each of 7.5 mm.

In the same conditions of use as for the CKSR example here before, the result would be the following:

According to EN 50178 and IEC 61010-1 standards:

Basic or Single insulation → Rated insulation voltage: $600 V_{RMS}$.

Reinforced insulation → Rated insulation voltage: $404 V_{RMS}$ (interpolation) or $300 V_{RMS}$ (without interpolation).

With **CAS models**, not using the special primary pins footprint, the clearance and creepage distances are each of 7.7 mm (distances are higher compared to the CASR models as there are only 3 secondary pins versus 4 on the CASR models).

In the same conditions of use as for the CKSR example here before, the result would be the following:

According to EN 50178 and IEC 61010-1 standards:

Basic or Single insulation → Rated insulation voltage: $600 V_{RMS}$.

Reinforced insulation → Rated insulation voltage: $417 V_{RMS}$ (interpolation) or $300 V_{RMS}$ (without interpolation).

(Note: all these calculations are done with creepage and clearance distances taken on the transducer itself not mounted on a PCB).

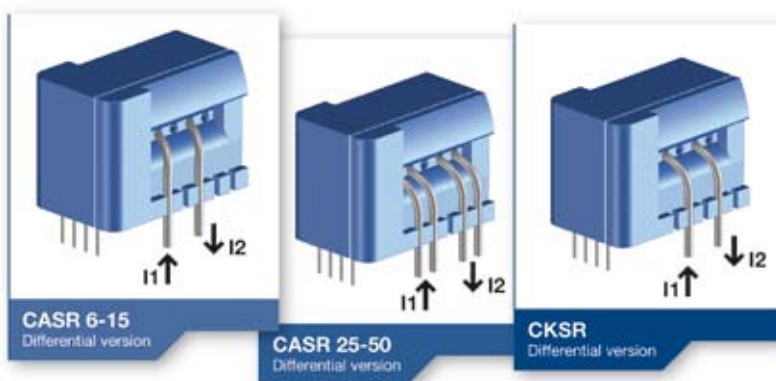


Fig. 6: Differential current measurement ($I = I1 - I2$), many possibilities

The measurement of differential currents is also possible with special versions of CAS, CASR and CKSR (Fig. 6). These models are possible on request. The current measured is the difference of the currents $I1 - I2$. For insulation reasons (creepage and clearance distances), these models are designed in order to have enough space between the 2 primary conductors carrying the 2 opposite currents (due to the possible potential difference between the two phases).

Electrical data

CAS/CASR/CKSR current transducers series have been designed to work with a single +5 V power supply to cover nominal current measurements from 6 to 50 A_{RMS}.

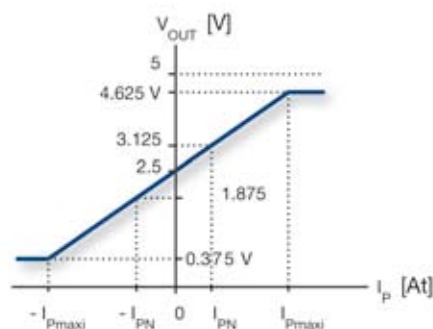
This is a common power supply used in the power electronics world to make working the various μ processors, or DSPs or ADCs (Analog Digital Converters) ect.

The models provide an analogue voltage output referenced around a reference voltage.

By default, this reference voltage is the internal reference voltage used inside the transducer: 2.5 V + a certain tolerance (please see adequate data sheet according to the model).

Then, at the output, these 2.5 V provided at no primary current can be considered as a virtual "0" V.

The gain is defined in order to get 0.625 V at I_{PN} whatever the model used (CAS or CASR or CKSR, 6 or 15 or 25 or 50 A_{RMS} models).



The output voltage range is limited to between 0.375 V for the negative current range and 4.625 V for the positive current range centred around 2.5 V when external reference voltage is not used.

The positive and negative voltage variation spans are each of 2.125 V and fluctuate around the internal voltage reference fixed at 2.5 V.

To define the measuring range, just divide the possible max voltage variation span (positive or negative) by the gain defined by the concerned model.

In general, the measuring range provided for each model is more than 3 times the nominal current.

For the 50 A models (CAS 50-NP, CASR 50-NP and CKSR 50-NP), the current measuring range is limited to +/- 150 A (nevertheless 3 times the nominal current) (due to some current limitations inside the transducer) meaning only 1.875 V as positive and negative variation spans, resulting in a minimum output voltage of 0.625 V for -150 A and in a maximum output voltage of 4.375 V for +150 A.

However, for these 50 A models, the limits for output voltage rails remain +0.375 V and +4.625 V.

With the CASR and CKSR models, the internal voltage reference is provided on a separate secondary additional pin called V_{REF} what is not the case with the CAS models.

This pin is a direct access to the voltage reference used inside set around 2.5 V.

The Ref pin has two basic functional modes:

The first mode is called "Ref out mode". In this mode, for a primary current of 0 A, the output voltage is equal to the

voltage at the Ref pin + an offset depending to the model used (between the voltage output and the Ref pin).

The voltage provided at the Ref pin (Typically 2.5 V) stays stable although the primary current changes.

The second mode is called "Ref in mode". In this mode, you can apply an external voltage to the Ref pin to overdrive the internal voltage reference. The minimum external voltage is 0 V and maximum 4 V. However, this mode defines different measuring ranges according to the level of the external voltage reference used (0 to 4 V) and according to the model used (6, 15, 25 or 50 A model).

For more information on these 2 modes, please refer to the chapter "Application advice".

With zero primary current, the consumption is max 20 mA. With more than zero primary current, the transducer consumes 20 mA max + (the primary current divided by the number of turns used by the transducer: I_P / N_s).

Accuracy

Using a Closed Loop Fluxgate technology allows reaching accuracy that was impossible with traditional Closed Loop Hall effect based technology (even with a dedicated ASIC).

Some applications required higher accuracy especially for lower offset and gain drifts in temperature ranges.

CAS/CASR/CKSR models achieve an accuracy of 0.8 % of I_{PN} at +25°C regardless of the model and the following accuracy at +85°C:

CAS: 2.5 to 3 % of I_{PN}

CASR: 1.2 to 1.8 % of I_{PN}

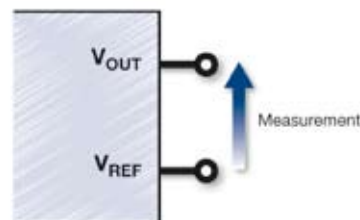
CKSR: 1.2 to 1.8 % of I_{PN}

As you can see, the accuracy of the CAS is less good as the CASR and CKSR models.

This is explained as follows: The CAS models do not provide the internal voltage reference outside and then the voltage output integrating the voltage reference inaccuracy.

What is not the case with the CASR and CKSR models providing their internal voltage reference outside or being able to feed their internal voltage reference with an external voltage reference. When using both these last models (CASR and CKSR), the output (V_{OUT}) is usually measured referenced to the voltage available on the voltage reference pin (which one is used as reference for the whole electronic of the application).

The voltage reference value available on this pin being well known and under control (used and usually controlled by the microcontroller or DSP), the microcontroller can easily remove the initial offset at +25°C at no primary current.









It is also possible to cancel the offset drift of the reference voltage when working over the defined temperature range by using the same method.

The use of the **Closed Loop Fluxgate technology** allowed achieving significantly better performances for the following parameters:

- Initial offset at +25°C
- Offset drift
- Gain drift

as expressed per the following charts (Fig. 7: Comparison between CAS and LTS ; CASR and LTSR models).

		CAS 6-NP		LTS 6-NP		CAS 15-NP		LTS 15-NP		CAS 25-NP		LTS 25-NP	
													
Nominal current, I_{PN}	A	6		15		25							
Measuring range	A	20	19.2	51	48	85	80						
Response time	us	< 0.3	0.4	< 0.3	0.4	< 0.3	0.4						
Bandwidth (± 1 dB)	kHz	200	200	200	200	200	200						
Output voltage noise, 100 Hz..10 kHz (typ.)	mVpp	2.4	10	1.0	4.2	0.6	2.5						
Output		Voltage		Voltage		Voltage							
Sensitivity	mV/A	104.2		41.7		25.0							
Sensitivity error (max)	% of I_{PN}	0.7	0.6	0.7	0.6	0.7	0.6						
Offset drift (25°C .. 85°C) (max)	% of I_{PN}	1.92	4.8	1.68	2.9	1.44	2.4						
Sensitivity drift (25°C .. 85°C) (max)	% of I_{PN}	0.24	0.3	0.24	0.3	0.24	0.3						
Linearity (max)	% of I_{PN}	0.1	0.1	0.1	0.1	0.1	0.1						
Accuracy at +25 °C (max)	% of I_{PN}	0.80	0.70	0.80	0.70	0.80	0.70						
Accuracy at +85 °C (max)	% of I_{PN}	3.0	5.80	2.7	3.58	2.5	3.40						
Offset (max)	mV	10.4	25	7.1	25	6.3	25						
Operating temperature range	°C	-40 .. 85		-40 .. 85		-40 .. 85							







		CASR 6-NP		LTSR 6-NP		CASR 15-NP		LTSR 15-NP		CASR 25-NP		LTSR 25-NP	
													
Nominal current, I_{PN}	A	6		15		25							
Measuring range	A	20	19.2	51	48	85	80						
Response time	us	< 0.3	0.4	< 0.3	0.4	< 0.3	0.4						
Bandwidth (± 1 dB)	kHz	200	200	200	200	200	200						
Output voltage noise, 100 Hz..10 kHz (typ.)	mVpp	1.7	10	0.7	4.2	0.4	2.5						
Output		Voltage		Voltage		Voltage							
Sensitivity	mV/A	104.2		41.7		25.0							
Sensitivity error (max)	% of I_{PN}	0.7	0.6	0.7	0.6	0.7	0.6						
Offset drift (25°C .. 85°C) (max)	% of I_{PN}	0.72	3.6	0.48	1.5	0.24	0.9						
Sensitivity drift (25°C .. 85°C) (max)	% of I_{PN}	0.24	0.3	0.24	0.3	0.24	0.3						
Linearity (max)	% of I_{PN}	0.1	0.1	0.1	0.1	0.1	0.1						
Accuracy at +25 °C (max)	% of I_{PN}	0.8	0.70	0.8	0.70	0.8	0.70						
Accuracy at +85 °C (max)	% of I_{PN}	1.8	4.60	1.5	2.54	1.3	1.90						
Offset max	mV	5.3	25	2.2	25	1.4	25						
Operating temperature range	°C	-40 .. 85		-40 .. 85		-40 .. 85							

Fig. 7. Comparison between CAS and LTS ; CASR and LTSR models – Electrical performances

Dynamic performances

CAS/CASR/CKSR transducers max response times (Response time defined at 90 % of I_{PN}) against a current step at I_{PN} will have a delay of Max $0.3 \mu\text{s}$ (Fig. 8).

As a result of the fast response time, a large bandwidth has been verified at 300 kHz @ +/- 3 dB (Fig. 9).

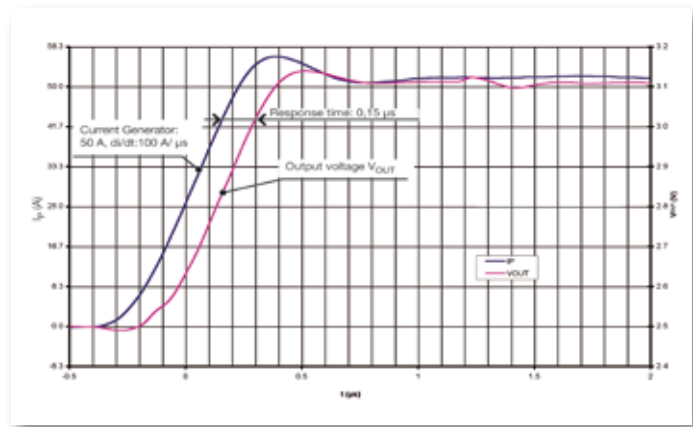


Fig. 8. CASR 50-NP Response time to a current step of 50 A

Fig. 10a. Typical common mode behaviour (1200 V of voltage variation applied with $dv/dt = 20 \text{ kV}/\mu\text{s}$)

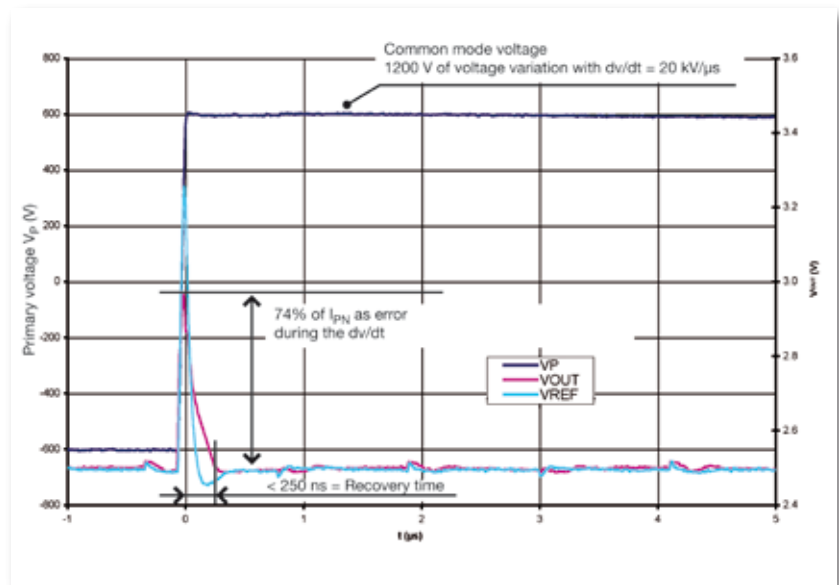
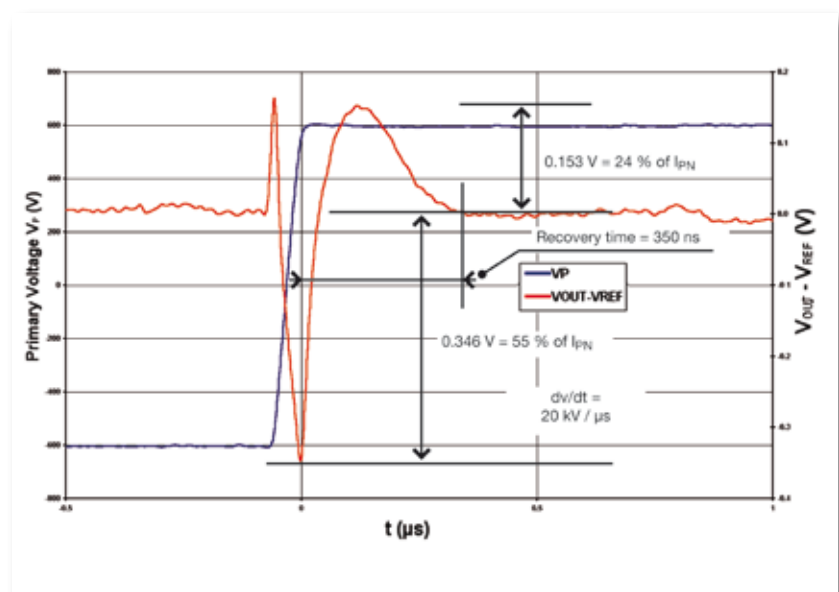


Fig. 10b. CASR 50-NP ; Typical common mode behaviour ; $V_{OUT} - V_{REF}$; (1200 V of voltage variation applied with $dv/dt = 20 \text{ kV}/\mu\text{s}$)



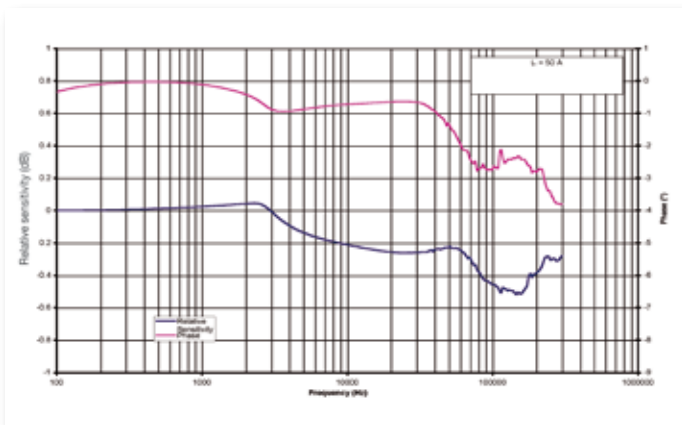


Fig. 9. CASR 50-NP - Frequency response

Common mode behaviour

Common mode noises (dv/dt) are often encountered in applications using fast switching components like IGBTs. It is not surprising to encounter switching frequencies up to and even higher than 20 kHz for highly efficient inverters.

The result of a dv/dt between the primary conductor and the electronic circuit of a current transducer is a capacitive current perturbing the various electronic components that are sensitive to that.

Any electrical component with a galvanic isolation between the primary and the secondary circuit has a capacitive coupling between the isolated potentials.

This capacitive current results in an additional error on the transducer output during a short time.

The error caused by these dv/dt has to be as low as possible in order to avoid any unwanted activation of a possible protection circuit, which could lead to a shut down of the application.

This additional noise caused by the dv/dt can be filtered, but the best way is to have it at the lowest possible value and during the shortest time avoiding then any additional filter to be installed.

For example, a voltage change of $10 \text{ kV}/\mu\text{s}$ in combination with a 10 pF coupling capacity generates a parasitic output current of 100 mA . For the CAS 25-NP for example, this would represent seven times the nominal current.

Fig. 10a shows the behaviour at a voltage change of $20 \text{ kV}/\mu\text{s}$ and an applied voltage of $+600 \text{ V}$ (total voltage variation of 1200 V from -600 V to $+600 \text{ V}$) with a CASR 50-NP.

Due to CAS-CASR-CKSR low parasitic capacitance, the effect of dynamic common mode is reduced. We can notice an interference of about 74 % of I_{PN} during the dv/dt when measurement V_{OUT} is referenced to 0 V . Note the **very short duration of the disturbance of less than 250 ns**, which can be easily filtered. When V_{OUT} is referenced to V_{REF} to do the output measurement, then the disturbance during dv/dt seen on the output is equal to the difference between the disturbance on V_{OUT} and the disturbance on V_{REF} (Fig. 10b). In these conditions, we can notice on the output signal ($V_{OUT} - V_{REF}$) an interference of about 55 % of I_{PN} during the dv/dt and 24 % of I_{PN} after the dv/dt , the signal coming back to its normal state only 350 ns after the end of the dv/dt .

Standards

The CAS/CASR/CKSR models have been designed and tested according to latest recognized worldwide standards for industrial applications:

The **EN 50178** standard dedicated to “Electronic Equipment for use in power installations” in industrial applications is our standard of reference for electrical, environmental and mechanical parameters.

It guarantees the overall performances of our products in industrial environments.

CAS/CASR/CKSR products are **CE marked** as a guarantee of the products compliance to the **European EMC directive 89/336/EEC** and **low voltage directive**. They also comply with the derived local EMC regulations (EMC: Electro-Magnetic Compatibility).



Insulation and safety

The **EN 50178** and **IEC 61010-1** standards (“Safety requirements for electrical equipment for measurement, control, and laboratory use”) are used as references to design the creepage and clearance distances versus the needed insulation levels (rated insulation voltage) and the conditions of use (as previously seen page 7).

The rated insulation voltage level for transducers in “industrial” applications, is defined according to several criteria listed under the both standards EN 50178 and IEC 61010-1. Some criteria are dependent on the transducer itself when the others are linked to the application.

The products comply with **UL 508C** for **UR marking**.



Reliability and Quality

Of course, reliability and lifetime are guaranteed by the quality in design and process. Accelerated tests have been performed to estimate failure rate (temperature cycle and/or humidity test and complete characterization of the product according to standards).

Beside, the CAS/CASR/CKSR models have been designed to **pass the $+85^\circ\text{C} + 85\%$ relative humidity test during 1000 hours** (transducers power supplied during the test).

The CAS/CASR/CKSR models are manufactured in one of the LEM production center that is ISO/TS 16949, ISO 14001, ISO 9001:2000 and IRIS certified and where quality tools such as DPT FMEA, Control Plan, Cpk, R&R, QOS-8D, IPQ, ect are used in addition to the Six Sigma methodology.

Filtering Vout

The output Vout has a very low output impedance of typically 2 Ω; it can drive 100 pF directly and shows 50% overshoot with approximately 1 nF capacitance. Adding Rf allows much larger capacitive loads. Note that with Rf of only 20 Ω, the load capacitor should be either smaller than 1 nF or larger than 33 nF to avoid overshoot; with Rf of 50 Ω this transient area is avoided.

Empirical evaluation may be necessary to obtain optimum results.

Example: Filtering the typical 450 kHz frequency of the detector:

To have an attenuation of 20 dB at 450 kHz, the cutting frequency of the 1st order filter is chosen at Fc=45 kHz.

To avoid transient area, the resistance Rf is chosen at 50 Ω.

The filter capacitor is then as per Fig. 11.

Load output resistance: R_L

The minimum load resistance of Vout is 1 kOhm.

Reference Voltage

If the Ref pin of the transducer is not used it must be left unconnected.

No special filtering is needed for Ref pin.

The Ref pin has two modes Ref in and Ref out:

- In the **Ref out mode**, the 2.5 V internal precision reference is used by the transducer as the reference point for bipolar measurements; this internal reference is connected to the Ref pin of the transducer through a 680 Ω resistor. It tolerates sink or source currents up to ±5 mA, but the 680 Ω resistor prevents this current to exceed these limits.

When the Ref pin is connected to a load, due to the leakage current and internal resistance (680 Ω), V_{REF} OUT (internal reference) can change and reduce the measuring range. To guarantee the measuring range:

- The leakage current from the Ref pin (source) must be lower than 350 μA when the load is connected to a voltage > 2.5 V.
- The leakage current from the Ref pin (sink) must be lower than 4.4 μA when the load is connected to a voltage < 2.5 V.
- In the **Ref in mode**, an external reference voltage is connected to the Ref pin; this voltage is specified in the range 0 to 4 V and is directly used by the transducer as the reference point for measurements.

The external reference voltage V_{REF} must be able:

- Either to source a typical current of $\frac{V_{ref} - 2.5}{680}$, the maximum value will be 2.2 mA typ. when V_{REF} = 4 V.
- Or to sink a typical current of $\frac{2.5 - V_{ref}}{680}$, the maximum value will be 3.68 mA typ. when V_{REF} = 0 V.

By using an external reference, it is easier to connect the transducer to devices such as an ADC.

In most applications, the output of the transducer is connected to an ADC whose output is processed by a DSP or a microcontroller.

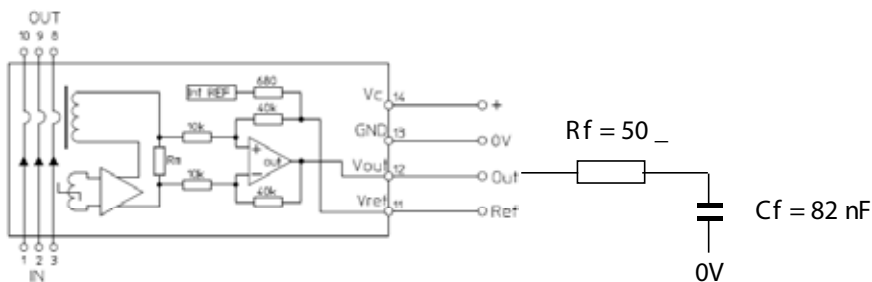
The internal reference of these DSPs or ADCs can go down to 1.8 V.

In this application, if you have an internal reference in the DSP with external access, you can supply the transducer's reference in with it.

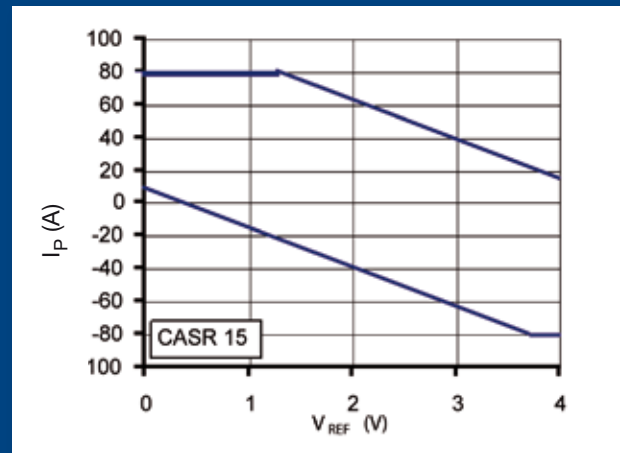
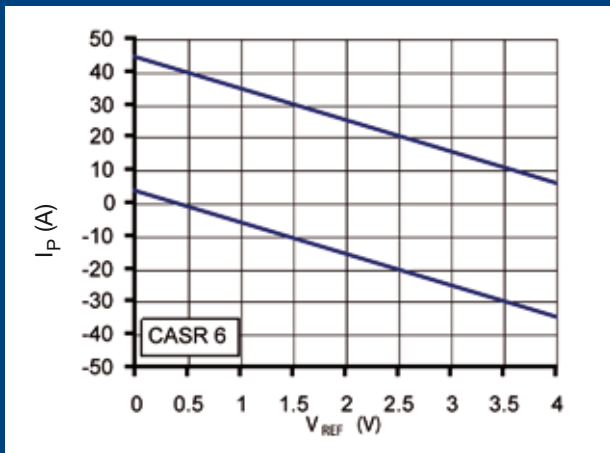
Fig. 11.

$$C_f = \frac{1}{2 * \pi * R_f * F_c} \quad C_f = \frac{1}{2 * \pi * 50 * 45E3}$$

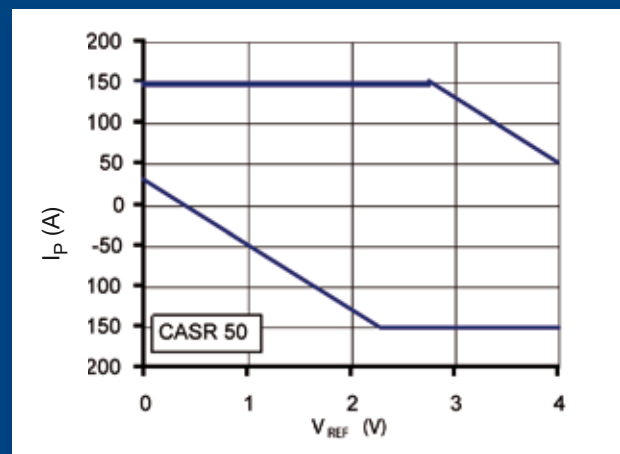
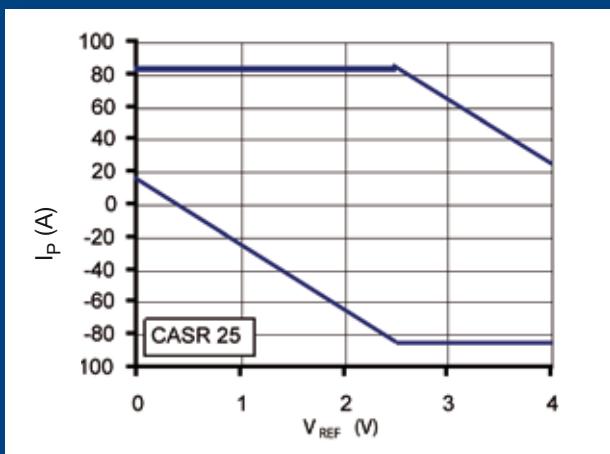
$$C_f \geq 70.7 \text{ nF}$$



The following graphs show how the measuring range of each transducer version depends on the external reference voltage value V_{REF} :



Upper limit: $I_p = -9.6 \times V_{REF} + 44.4$ ($V_{REF} = 0 \dots 4$ V)	Upper limit: $I_p = -24 \times V_{REF} + 111$ ($V_{REF} = 1.29 \dots 4$ V)
Lower limit: $I_p = -9.6 \times V_{REF} + 3.6$ ($V_{REF} = 0 \dots 4$ V)	Upper limit: $I_p = 80$ ($V_{REF} = 0 \dots 1.29$ V)
	Lower limit: $I_p = -24 \times V_{REF} + 9$ ($V_{REF} = 0 \dots 3.7$ V)
	Lower limit: $I_p = -80$ ($V_{REF} = 3.7 \dots 4$ V)



Upper limit: $I_p = -40 \times V_{REF} + 185$ ($V_{REF} = 2.5 \dots 4$ V)	Upper limit: $I_p = -80 \times V_{REF} + 370$ ($V_{REF} = 2.75 \dots 4$ V)
Upper limit: $I_p = 85$ ($V_{REF} = 0 \dots 2.5$ V)	Upper limit: $I_p = 150$ ($V_{REF} = 0 \dots 2.75$ V)
Lower limit: $I_p = -40 \times V_{REF} + 15$ ($V_{REF} = 0 \dots 2.5$ V)	Lower limit: $I_p = -80 \times V_{REF} + 30$ ($V_{REF} = 0 \dots 2.25$ V)
Lower limit: $I_p = -85$ ($V_{REF} = 2.5 \dots 4$ V)	Lower limit: $I_p = -150$ ($V_{REF} = 2.25 \dots 4$ V)

Example with $V_{REF} = 1.65$ V:

- The 6 A version has a measuring range from -12.24 A to +28.5 A
- The 15 A version has a measuring range from -30.6 A to +71.4 A
- The 25 A version has a measuring range from -51 A to +85 A
- The 50 A version has a measuring range from -102 A to +150 A

Example with $V_{REF} = 0$ V:

- The 6 A version has a measuring range from +3.6 A to +44.4 A
- The 15 A version has a measuring range from +9 A to +80 A
- The 25 A version has a measuring range from +15 A to +85 A
- The 50 A version has a measuring range from +30 A to +150 A

Primary conductor resistance

At 25 °C, one primary conductor has a resistance of 0.72 mΩ typ.

At 85 °C, one primary conductor has a resistance of 0.88 mΩ typ.

Number of primary conductor	Connection	Temperature	Resistance typ.
3	Parallel	25° C	0.24 mΩ
4	Parallel	25° C	0.18 mΩ
3	Parallel	85° C	0.29 mΩ
4	Parallel	85° C	0.22 mΩ
3	Series	25° C	2.16 mΩ
4	Series	25° C	2.88 mΩ
3	Series	85° C	2.64 mΩ
4	Series	85° C	3.52 mΩ



Typical applications & conclusion

The CAS/CASR/CKSR current transducers have been designed mainly for industrial applications requiring:

- **Good accuracy** especially in temperature (low initial offset, low thermal drifts for gain and offset)
- **Reduced size:** CAS/CASR/CKSR are the smallest on the market in their category (up to nominal current of $50 A_{RMS}$)
- **High immunity against high voltage variations**
- **High flexibility** for specific customer applications (wide choice of current ranges: 6, 15, 25 and $50 A_{RMS}$, each model is **multi range**, unique packaging)
- **High Creepage and Clearance distances** with the CKSR models for **higher insulation**
- Measures the same given performance current as small as **$1.5 A_{RMS}$** with the CKSR 6-NP model
- Resistant in rough environmental conditions of use such as **high humidity combined with high temperature**

These advantages are suited for high performance drives, inverters for new energy integrating a good control of the DC current injection in the grid, servo drives for wafers production or highly accurate robots and all kinds of low drift applications. After all, they have been created to achieve great performance not only today - but as far into the future as you can imagine.



Absolute maximum ratings

Parameter	Symbol	Unit	Value
Supply voltage	V_C	V	7
Primary conductor temperature		°C	110
ESD rating, Human Body Model (HBM)		kV	4

Stresses above these ratings may cause permanent damage. Exposure to absolute maximum ratings for extended periods may degrade reliability.

Isolation characteristics

Parameter		Unit	CAS Value	CASR Value	CKSR Value	Comment
RMS voltage for AC isolation test 50/60Hz/1 min	V_d	kV	4.2	4.1	4.3	
Impulse withstand voltage 1.2/50 μ s	\hat{V}_w	kV	7.6	7.5	8	
Partial discharge extinction voltage @ 10 pC (rms)	V_e	V	1000	1000	1000	
Clearance distance (pri. - sec.)	dCl	mm	7.7	7.5	8.2	Shortest distance through air
Creepage distance (pri. - sec.)	dCp	mm	7.7	7.5	8.2	Shortest path along device body (CAS-CASR) Shortest internal path along device body (CKSR)
Creepage distance (pri. - sec.)	-	mm	6.3	6.2	-	When mounted on PCB with recommended layout (CAS-CASR)
Case material	-	-	V0 according to UL 94	V0 according to UL 94	V0 according to UL 94	
Comparative tracking index	CTI	V	600	600	600	
Application example	-	-	300 V CAT III PD2	300 V CAT III PD2	300 V CAT III PD2	Reinforced isolation, non uniform field according to EN 50178, EN 61010, IEC 60364-4-43
Application example	-	-	600 V CAT III PD2	600 V CAT III PD2	1000 V CAT III PD2	Simple isolation, non uniform field according to EN 50178, EN 61010, IEC 60364-4-43

Environmental and mechanical characteristics

Parameter	Symbol	Unit	Min	Typ	Max	Comment
Ambient operating temperature	T_A	°C	-40		85	
Ambient storage temperature	T_S	°C	-50		105	
Mass	m	g		9		
Standards	EN 50178, IEC 60950-1, IEC 61010-1, IEC 61326-1, UL 508C					

Electrical data CAS/CASR/CKSR 6-NP

At $T_A = 25^\circ\text{C}$, $V_C = +5\text{ V}$, $N_p = 1$ turn, $R_L = 10\text{ k}\Omega$, (internal reference for CASR & CKSR models) unless otherwise noted.

Parameter	Symbol	Unit	Min	Typ	Max	Comment
Primary nominal current rms	I_{PN}	A		6		
Primary current, measuring range	I_{PM}	A	-20		20	
Number of primary turns	N_p	-		1,2,3		for CAS / CASR
		-		1,2,3,4		for CKSR
Supply voltage	V_C	V	4.75	5	5.25	
Current consumption	I_C	mA		$15 + \frac{I_p(\text{mA})}{N_s}$	$20 + \frac{I_p(\text{mA})}{N_s}$	$N_s = 1731$ turns
Reference voltage @ $I_p = 0\text{ A}$	V_{REF}	V	2.495	2.5	2.505	Internal reference for CASR / CKSR
External reference voltage	V_{REF}	V	0		4	for CASR / CKSR
Output voltage	V_{OUT}	V	0.375		4.625	
Output voltage @ $I_p = 0\text{ A}$	V_{OUT}	V		2.5		for CAS
				V_{REF}		for CASR / CKSR
Electrical offset voltage	V_{OE}	mV	-10.4		10.4	100% tested $V_{OUT} - 2.5\text{ V}$ for CAS $V_{OUT} - V_{REF}$ for CASR / CKSR
			-5.3		5.3	
Electrical offset current referred to primary	I_{OE}	A	-0.1		0.1	100% tested for CAS
		mA	-51		51	100% tested for CASR / CKSR
Temperature coefficient of V_{REF}	TCV_{REF}	ppm/K		± 5	± 50	Internal reference for CASR / CKSR
Temperature coefficient of V_{OUT} @ $I_p = 0\text{ A}$	TCV_{OUT}	ppm/K		± 10	± 80	ppm/K of 2.5 V - 40°C .. 85°C for CAS
				± 6	± 30	ppm/K of 2.5 V - 40°C .. 85°C for CASR / CKSR
Theoretical sensitivity	Gth	mV/A		104.2		625 mV / I_{PN}
Sensitivity error	ϵ_G	%	-0.7		0.7	100% tested
Temperature coefficient of G	TCG	ppm/K			± 40	- 40°C .. 85°C
Linearity error	ϵ_L	% of I_{PN}	-0.1		0.1	
Magnetic offset current (10 x I_{PN}) referred to primary	I_{OM}	A	-0.1		0.1	
Output current noise (spectral density) rms 100 Hz .. 100 kHz referred to primary	i_{no}	$\mu\text{A}/\text{Hz}^{1/2}$		36		$R_L = 1\text{ k}\Omega$ for CAS
				20		$R_L = 1\text{ k}\Omega$ for CASR / CKSR
Peak-peak output ripple at oscillator frequency $f = 450\text{ kHz}$ (typ.)	-	mV		40	160	$R_L = 1\text{ k}\Omega$
Reaction time @ 10 % of I_{PN}	t_{ra}	μs			0.3	$R_L = 1\text{ k}\Omega$ $di/dt = 18\text{ A}/\mu\text{s}$
Response time @ 90 % of I_{PN}	t_r	μs			0.3	$R_L = 1\text{ k}\Omega$ $di/dt = 18\text{ A}/\mu\text{s}$
Frequency bandwidth ($\pm 1\text{ dB}$)	BW	kHz	200			$R_L = 1\text{ k}\Omega$
Frequency bandwidth ($\pm 3\text{ dB}$)	BW	kHz	300			$R_L = 1\text{ k}\Omega$
Overall accuracy	X_G	% of I_{PN}			2.5	for CAS
					1.7	for CASR / CKSR
Overall accuracy @ $T_A = 85^\circ\text{C}$	X_G	% of I_{PN}			4.6	for CAS
					2.6	for CASR / CKSR
Accuracy	X	% of I_{PN}			0.8	
Accuracy @ $T_A = 85^\circ\text{C}$	X	% of I_{PN}			3.0	for CAS
					1.8	for CASR / CKSR

Electrical data CAS/CASR/CKSR 15-NP

At $T_A = 25^\circ\text{C}$, $V_C = +5\text{ V}$, $N_P = 1\text{ turn}$, $R_L = 10\text{ k}\Omega$, (internal reference for CASR & CKSR models) unless otherwise noted.

Parameter	Symbol	Unit	Min	Typ	Max	Comment
Primary nominal current rms	I_{PN}	A		15		
Primary current, measuring range	I_{PM}	A	-51		51	
Number of primary turns	N_P	-		1,2,3		for CAS / CASR
		-		1,2,3,4		for CKSR
Supply voltage	V_C	V	4.75	5	5.25	
Current consumption	I_C	mA		$15 + \frac{I_p(\text{mA})}{N_s}$	$20 + \frac{I_p(\text{mA})}{N_s}$	$N_s = 1731\text{ turns}$
Reference voltage @ $I_p = 0\text{ A}$	V_{REF}	V	2.495	2.5	2.505	Internal reference for CASR / CKSR
External reference voltage	V_{REF}	V	0		4	for CASR / CKSR
Output voltage	V_{OUT}	V	0.375		4.625	
Output voltage @ $I_p = 0\text{ A}$	V_{OUT}	V		2.5		for CAS
				V_{REF}		for CASR/CKSR
Electrical offset voltage	V_{OE}	mV	-7.1		7.1	100% tested $V_{OUT} - 2.5\text{ V}$ for CAS
			-2.21		2.21	$V_{OUT} - V_{REF}$ for CASR / CKSR
Electrical offset current referred to primary	I_{OE}	A	-0.17		0.17	100% tested for CAS
		mA	-53		53	100% tested for CASR/CKSR
Temperature coefficient of V_{REF}	TCV_{REF}	ppm/K		± 5	± 50	Internal reference for CASR/CKSR
Temperature coefficient of V_{OUT} @ $I_p = 0\text{ A}$	TCV_{OUT}	ppm/K		± 7.5	± 70	ppm/K of $2.5\text{ V} - 40^\circ\text{C} \dots 85^\circ\text{C}$ for CAS
				± 2.3	± 20	ppm/K of $2.5\text{ V} - 40^\circ\text{C} \dots 85^\circ\text{C}$ for CASR / CKSR
Theoretical sensitivity	Gth	mV/A		41.67		$625\text{ mV} / I_{PN}$
Sensitivity error	ϵ_G	%	-0.7		0.7	100% tested
Temperature coefficient of G	TCG	ppm/K			± 40	$-40^\circ\text{C} \dots 85^\circ\text{C}$
Linearity error	ϵ_L	% of I_{PN}	-0.1		0.1	
Magnetic offset current ($10 \times I_{PN}$) referred to primary	I_{OM}	A	-0.1		0.1	
Output current noise (spectral density) rms 100 Hz .. 100 kHz referred to primary	i_{no}	$\mu\text{A}/\text{Hz}^{1/2}$		90		$R_L = 1\text{ k}\Omega$ for CAS
				20		$R_L = 1\text{ k}\Omega$ for CASR / CKSR
Peak-peak output ripple at oscillator frequency $f = 450\text{ kHz}$ (typ.)	-	mV		15	60	$R_L = 1\text{ k}\Omega$
Reaction time @ 10 % of I_{PN}	t_{ra}	μs			0.3	$R_L = 1\text{ k}\Omega$ $di/dt = 44\text{ A}/\mu\text{s}$
Response time @ 90 % of I_{PN}	t_r	μs			0.3	$R_L = 1\text{ k}\Omega$ $di/dt = 44\text{ A}/\mu\text{s}$
Frequency bandwidth ($\pm 1\text{ dB}$)	BW	kHz	200			$R_L = 1\text{ k}\Omega$
Frequency bandwidth ($\pm 3\text{ dB}$)	BW	kHz	300			$R_L = 1\text{ k}\Omega$
Overall accuracy	X_G	% of I_{PN}			1.9	for CAS
					1.2	for CASR/CKSR
Overall accuracy @ $T_A = 85^\circ\text{C}$	X_G	% of I_{PN}			3.9	for CAS
					1.9	for CASR / CKSR
Accuracy	X	% of I_{PN}			0.8	
Accuracy @ $T_A = 85^\circ\text{C}$	X	% of I_{PN}			2.7	for CAS
					1.5	for CASR / CKSR

Electrical data CAS/CASR/CKSR 25-NP

At $T_A = 25^\circ\text{C}$, $V_C = +5\text{ V}$, $N_p = 1$ turn, $R_L = 10\text{ k}\Omega$, (internal reference for CASR & CKSR models) unless otherwise noted.

Parameter	Symbol	Unit	Min	Typ	Max	Comment
Primary nominal current rms	I_{PN}	A		25		
Primary current, measuring range	I_{PM}	A	-85		85	
Number of primary turns	N_p	-		1,2,3		for CAS / CASR
		-		1,2,3,4		for CKSR
Supply voltage	V_C	V	4.75	5	5.25	
Current consumption	I_C	mA		$15 + \frac{I_p(\text{mA})}{N_s}$	$20 + \frac{I_p(\text{mA})}{N_s}$	$N_s = 1731$ turns
Reference voltage @ $I_p = 0\text{ A}$	V_{REF}	V	2.495	2.5	2.505	Internal reference for CASR / CKSR
External reference voltage	V_{REF}	V	0		4	for CASR / CKSR
Output voltage	V_{OUT}	V	0.375		4.625	
Output voltage @ $I_p = 0\text{ A}$	V_{OUT}	V		2.5		for CAS
		V		V_{REF}		for CASR / CKSR
Electrical offset voltage	V_{OE}	mV	-6.25		6.25	100% tested $V_{OUT} - 2.5\text{ V}$ for CAS $V_{OUT} - V_{REF}$ for CASR / CKSR
		mV	-1.35		1.35	
Electrical offset current referred to primary	I_{OE}	A	-0.25		0.25	100% tested for CAS
		mA	-54		54	100% tested for CASR / CKSR
Temperature coefficient of V_{REF}	TCV_{REF}	ppm/K		± 5	± 50	Internal reference for CASR / CKSR
Temperature coefficient of V_{OUT} @ $I_p = 0\text{ A}$	TCV_{OUT}	ppm/K		± 6.5	± 60	ppm/K of $2.5\text{ V} - 40^\circ\text{C} \dots 85^\circ\text{C}$ for CAS
				± 1.4	± 10	ppm/K of $2.5\text{ V} - 40^\circ\text{C} \dots 85^\circ\text{C}$ for CASR / CKSR
Theoretical sensitivity	Gth	mV/A		25		$625\text{ mV} / I_{PN}$
Sensitivity error	ϵ_G	%	-0.7		0.7	100% tested
Temperature coefficient of G	TCG	ppm/K			± 40	$-40^\circ\text{C} \dots 85^\circ\text{C}$
Linearity error	ϵ_L	% of I_{PN}	-0.1		0.1	
Magnetic offset current ($10 \times I_{PN}$) referred to primary	I_{OM}	A	-0.1		0.1	
Output current noise (spectral density) rms 100 Hz .. 100 kHz referred to primary	i_{no}	$\mu\text{A}/\text{Hz}^{1/2}$		150		$R_L = 1\text{ k}\Omega$ for CAS
				20		$R_L = 1\text{ k}\Omega$ for CASR / CKSR
Peak-peak output ripple at oscillator frequency $f = 450\text{ kHz}$ (typ.)	-	mV		10	40	$R_L = 1\text{ k}\Omega$
Reaction time @ 10 % of I_{PN}	t_{ra}	μs			0.3	$R_L = 1\text{ k}\Omega$ $di/dt = 68\text{ A}/\mu\text{s}$
Response time @ 90 % of I_{PN}	t_r	μs			0.3	$R_L = 1\text{ k}\Omega$ $di/dt = 68\text{ A}/\mu\text{s}$
Frequency bandwidth ($\pm 1\text{ dB}$)	BW	kHz	200			$R_L = 1\text{ k}\Omega$
Frequency bandwidth ($\pm 3\text{ dB}$)	BW	kHz	300			$R_L = 1\text{ k}\Omega$
Overall accuracy	X_G	% of I_{PN}			1.8	for CAS
					1	for CASR / CKSR
Overall accuracy @ $T_A = 85^\circ\text{C}$	X_G	% of I_{PN}			3.5	for CAS
					1.5	for CASR / CKSR
Accuracy	X	% of I_{PN}			0.8	
Accuracy @ $T_A = 85^\circ\text{C}$	X	% of I_{PN}			2.5	for CAS
					1.3	for CASR / CKSR

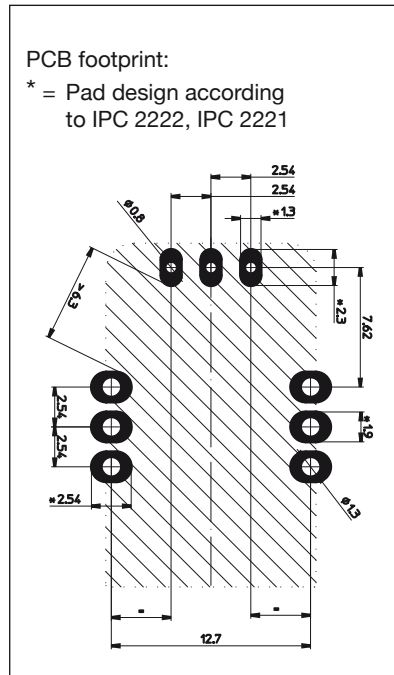
Electrical data CAS/CASR/CKSR 50-NP

At $T_A = 25^\circ\text{C}$, $V_C = +5\text{ V}$, $N_P = 1$ turn, $R_L = 10\text{ k}\Omega$, (internal reference for CASR & CKSR models) unless otherwise noted.

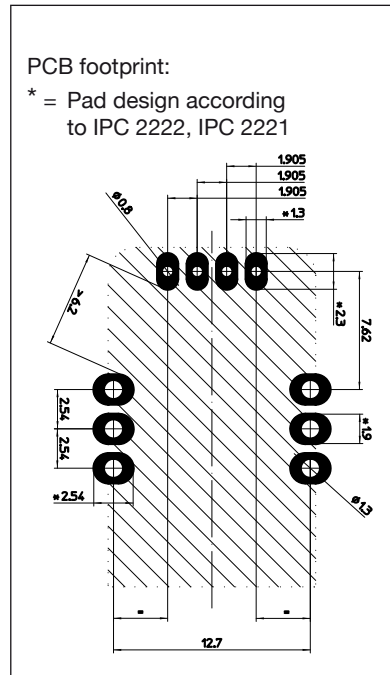
Parameter	Symbol	Unit	Min	Typ	Max	Comment
Primary nominal current rms	I_{PN}	A		50		
Primary current, measuring range	I_{PM}	A	-150		150	
Number of primary turns	N_P	-		1,2,3		for CAS / CASR
		-		1,2,3,4		for CKSR
Supply voltage	V_C	V	4.75	5	5.25	
Current consumption	I_C	mA		$15 + \frac{I_p(\text{mA})}{N_s}$	$20 + \frac{I_p(\text{mA})}{N_s}$	$N_s = 966$ turns
Reference voltage @ $I_p = 0\text{ A}$	V_{REF}	V	2.495	2.5	2.505	Internal reference for CASR / CKSR
External reference voltage	V_{REF}	V	0		4	for CASR / CKSR
Output voltage	V_{OUT}	V	0.375		4.625	
Output voltage @ $I_p = 0\text{ A}$	V_{OUT}	V		2.5		for CAS
		V		V_{REF}		for CASR/CKSR
Electrical offset voltage	V_{OE}	mV	-5.8		5.8	100% tested $V_{OUT} - 2.5\text{ V}$ for CAS $V_{OUT} - V_{REF}$ for CASR / CKSR
		mV	-0.725		0.725	
Electrical offset current referred to primary	I_{OE}	A	-0.46		0.46	100% tested for CAS
		mA	-58		58	100% tested for CASR/CKSR
Temperature coefficient of V_{REF}	TCV_{REF}	ppm/K		± 5	± 50	Internal reference for CASR/CKSR
Temperature coefficient of V_{OUT} @ $I_p = 0\text{ A}$	TCV_{OUT}	ppm/K		± 6	± 60	ppm/K of $2.5\text{ V} - 40^\circ\text{C} \dots 85^\circ\text{C}$ for CAS
		ppm/K		± 0.7	± 7	ppm/K of $2.5\text{ V} - 40^\circ\text{C} \dots 85^\circ\text{C}$ for CASR / CKSR
Theoretical sensitivity	Gth	mV/A		12.5		$625\text{ mV}/I_{PN}$
Sensitivity error	ϵ_G	%	-0.7		0.7	100% tested
Temperature coefficient of G	TCG	ppm/K			± 40	$-40^\circ\text{C} \dots 85^\circ\text{C}$
Linearity error	ϵ_L	% of I_{PN}	-0.1		0.1	
Magnetic offset current ($10 \times I_{PN}$) referred to primary	I_{OM}	A	-0.1		0.1	
Output current noise (spectral density) rms 100 Hz .. 100 kHz referred to primary	i_{no}	$\mu\text{A}/\text{Hz}^{1/2}$		300		$R_L = 1\text{ k}\Omega$ for CAS
		$\mu\text{A}/\text{Hz}^{1/2}$		20		$R_L = 1\text{ k}\Omega$ for CASR / CKSR
Peak-peak output ripple at oscillator frequency $f = 450\text{ kHz}$ (typ.)	-	mV		5	20	$R_L = 1\text{ k}\Omega$
Reaction time @ 10 % of I_{PN}	t_{ra}	μs			0.3	$R_L = 1\text{ k}\Omega$ $di/dt = 100\text{ A}/\mu\text{s}$
Response time @ 90 % of I_{PN}	t_r	μs			0.3	$R_L = 1\text{ k}\Omega$ $di/dt = 100\text{ A}/\mu\text{s}$
Frequency bandwidth ($\pm 1\text{ dB}$)	BW	kHz	200			$R_L = 1\text{ k}\Omega$
Frequency bandwidth ($\pm 3\text{ dB}$)	BW	kHz	300			$R_L = 1\text{ k}\Omega$
Overall accuracy	X_G	% of I_{PN}			1.7	for CAS
					0.9	for CASR/CKSR
Overall accuracy @ $T_A = 85^\circ\text{C}$	X_G	% of I_{PN}			3.4	for CAS
					1.3	for CASR / CKSR
Accuracy	X	% of I_{PN}			0.8	
Accuracy @ $T_A = 85^\circ\text{C}$	X	% of I_{PN}			2.5	for CAS
					1.2	for CASR / CKSR

PCB footprints

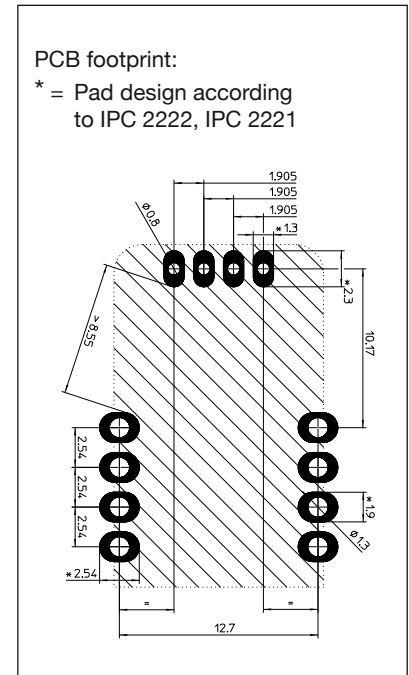
CAS Series



CASR Series



CKSR Series



Dimensions in mm. 1 mm = 0.0394 inches

Safety

Assembly on PCB

Recommended PCB hole diameter	1.3 mm for primary pin 0.8 mm for secondary pin
Maximum PCB thickness	2.4 mm
Wave soldering profile	maximum 260°C for 10 s
No clean process only.	



This transducer must be used in electric/electronic equipment with respect to applicable standards and safety requirements in accordance with the manufacturer's operating instructions



Caution, risk of electrical shock

When operating the transducer, certain parts of the module can carry hazardous voltage (eg. primary busbar, power supply).

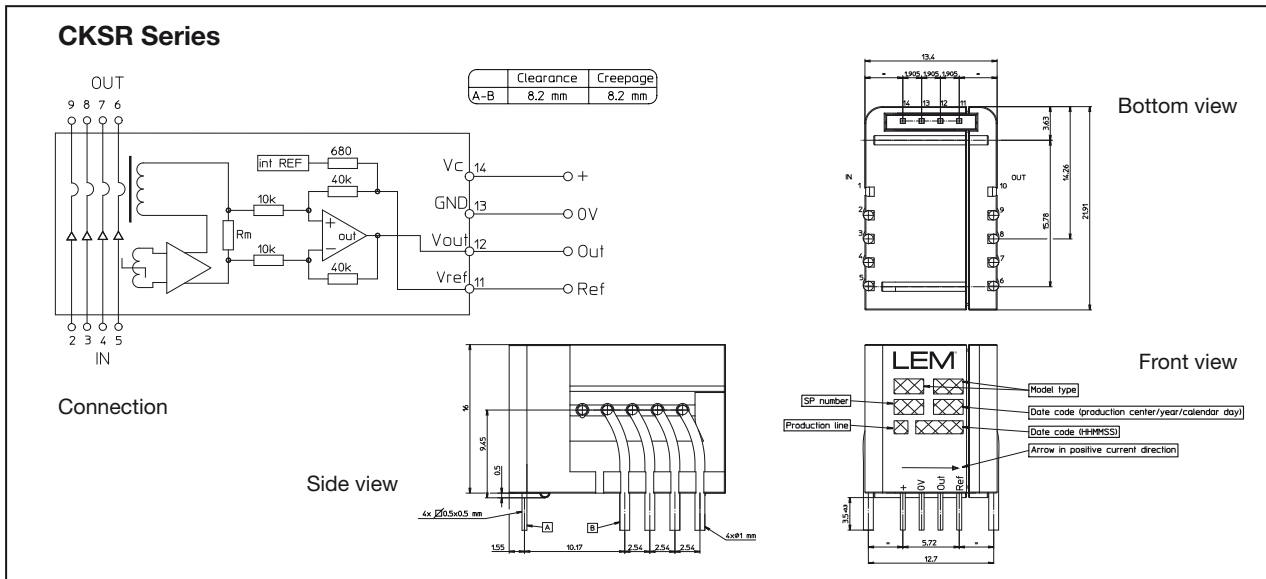
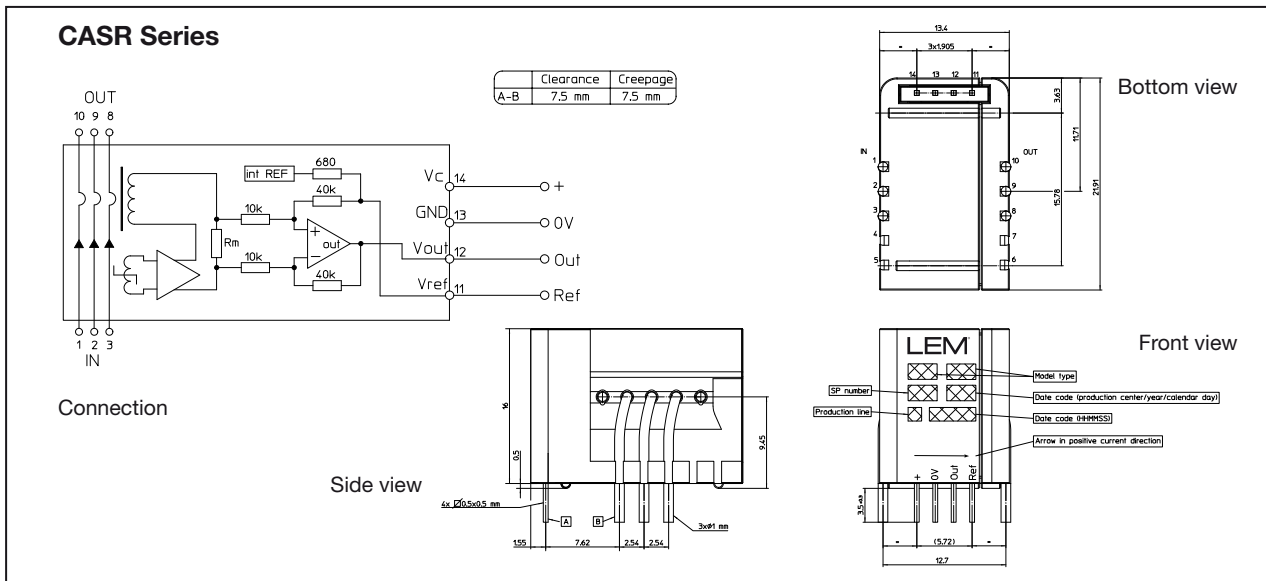
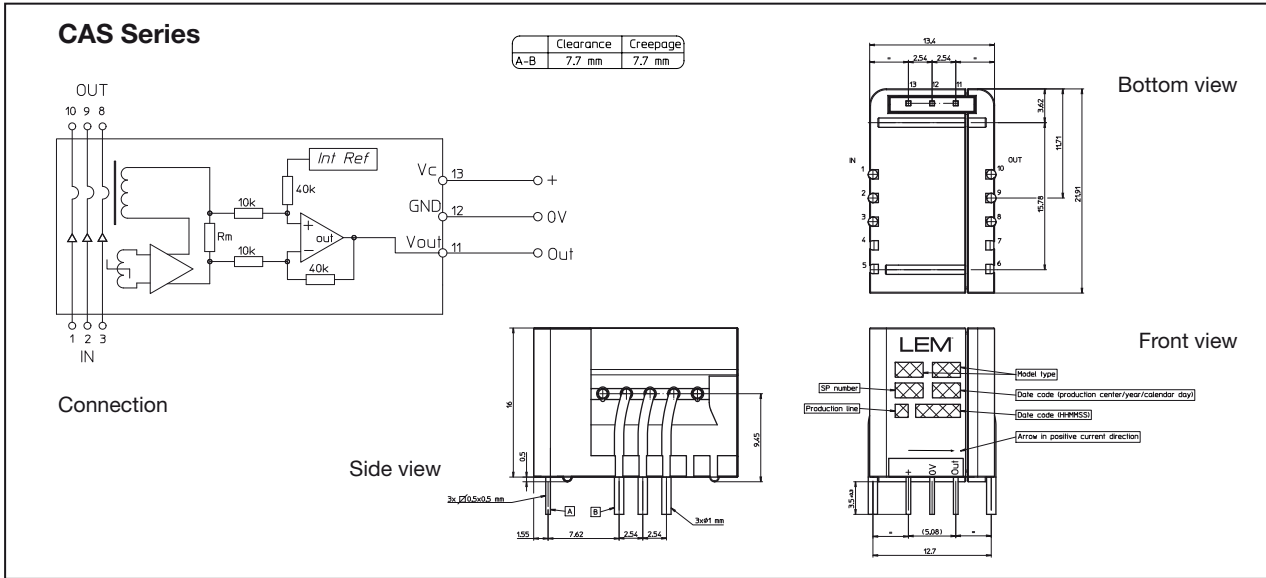
Ignoring this warning can lead to injury and/or cause serious damage.

This transducer is a built-in device, whose conducting parts must be inaccessible after installation.

A protective housing or additional shield could be used.

Main supply must be able to be disconnected.

Dimensions (in mm. General linear tolerance ± 0.25 mm)





5 Year Warranty on LEM Transducers

We design and manufacture high quality and highly reliable products for our customers all over the world.

We have delivered several million current and voltage transducers since 1972 and most of them are still being used today for traction vehicles, industrial motor drives, UPS systems and many other applications requiring high quality standards.

The LEM 5-year warranty applies to all LEM transducers and is valid in addition to the legal warranty.

The warranty granted on LEM transducers is for a period of 5 years (60 months) from the date of their delivery.

During this period LEM shall replace or repair all defective parts at its' cost (provided the defect is due to defective material or workmanship).

Additional claims as well as claims for the compensation of damages, which do not occur on the delivered material itself, are not covered by this warranty.

All defects must be notified to LEM immediately and faulty material must be returned to the factory along with a description of the defect.

Warranty repairs and or replacements are carried out at LEM's discretion.

The customer bears the transport costs. An extension of the warranty period following repairs undertaken under warranty cannot be granted.

The warranty becomes invalid if the buyer has modified or repaired, or has had repaired by a third party the material without LEM's written consent.

The warranty does not cover any damage caused by incorrect conditions of use and cases of force majeure.

No responsibility will apply except legal requirements regarding product liability.

The warranty explicitly excludes all claims exceeding the above conditions.

LEM, April 1. 2008

A handwritten signature in black ink, appearing to read "P. Van Iseghem".

Paul Van Iseghem
President & CEO LEM

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